Sea	earch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/659,503	ITO ET AL.	
Examiner	Art Unit	•
Huan H. Tran	2861	

			<b>,</b>
	SEAR	CHED	
Class	Subclass	Date	Examiner
347	197, 198	5/26/2005	ннт
400	120.16	5/26/2005	ННТ
400	120.17	5/26/2005	ННТ

TNI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY	<b>(</b> )
	DATE	EXMR
, , , , , , , , , , , , , , , , , , ,		
	,	